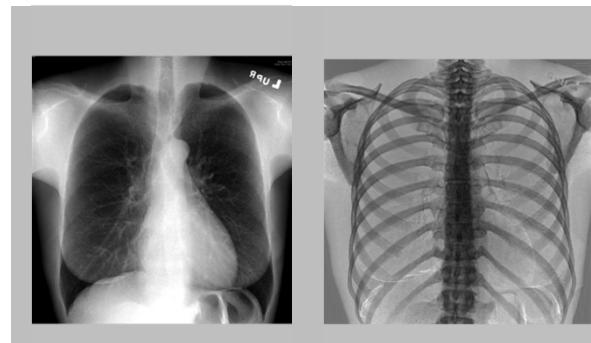
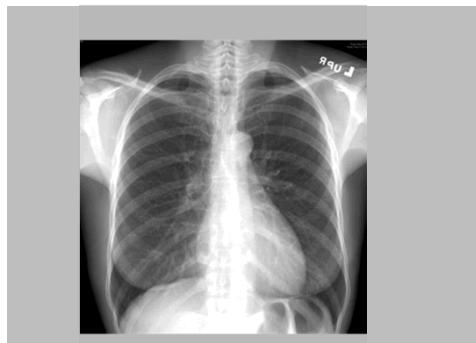
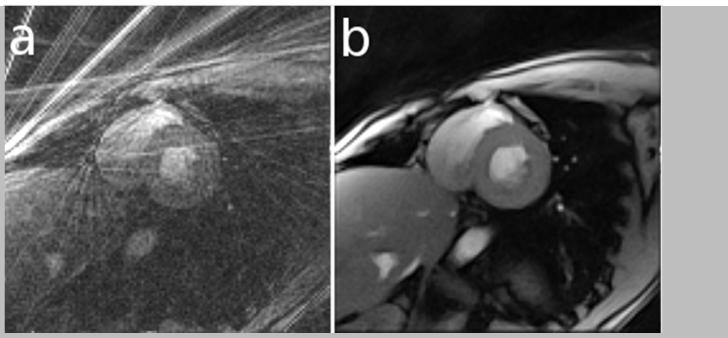


Exceptional service in the national interest



Comparing Imaging Capabilities of Multi-Channel Detectors to Traditional X-Ray Detector Technology for Industrial and Security Applications

**Edward S. Jimenez, Noelle M. Collins, Erica A. Holswade, Madison L. Devonshire,
and Kyle R. Thompson,**

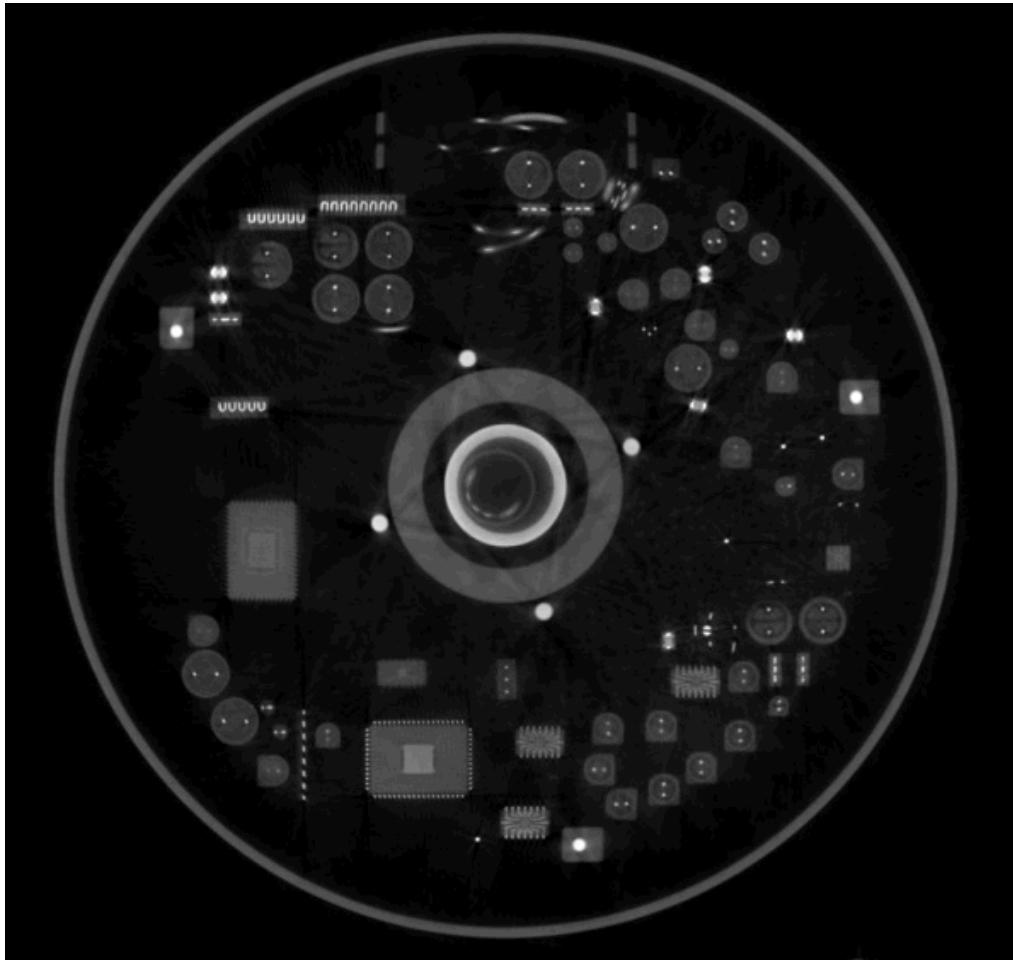


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Objective

- Create an advanced capability at Sandia National Laboratories
 - High Energy Color X-ray Imaging for R&D in Industrial and Security Applications.
- Industrial Applications
 - Verification and Validation
 - High-Magnification Computed Tomography
 - High-Energy Computed Tomography
 - Quality Assurance
 - Anomaly Detection
- Security Applications
 - Checkpoint Screening
 - Materials Identification
 - Real-time Multi-Energy CT

Example: CT Artifacts



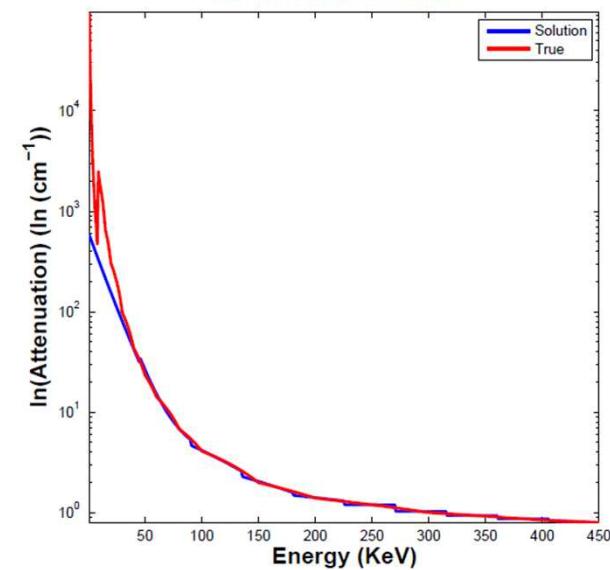
Example: Material Identification

Noise

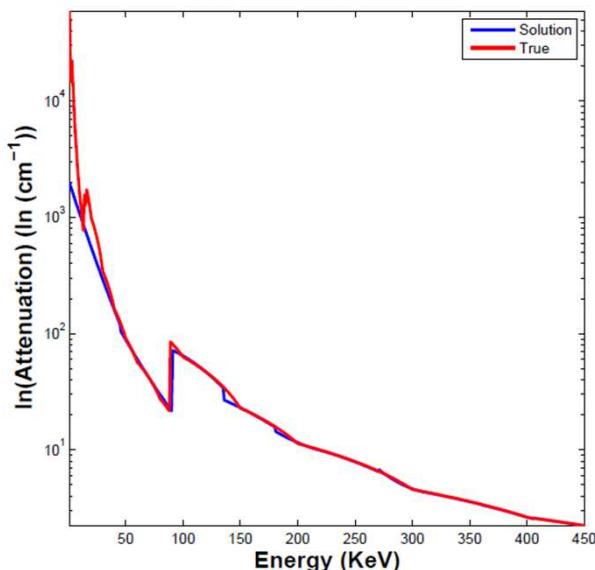
Constraints

Geometry

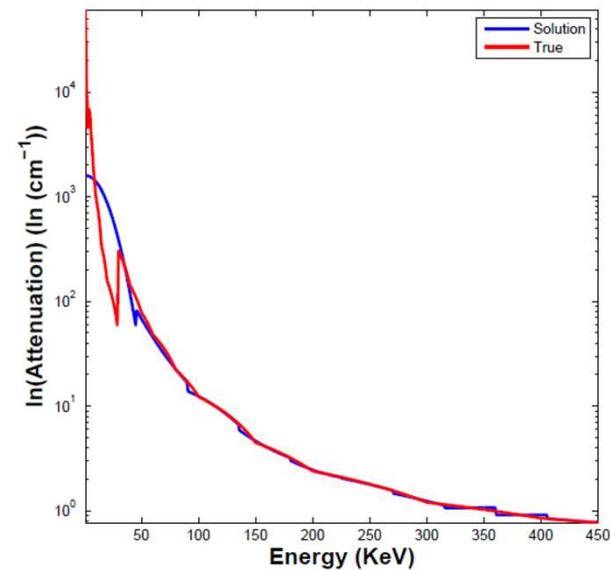
Cu Attenuation Estimate



Pb Attenuation Estimate



Sn Attenuation Estimate



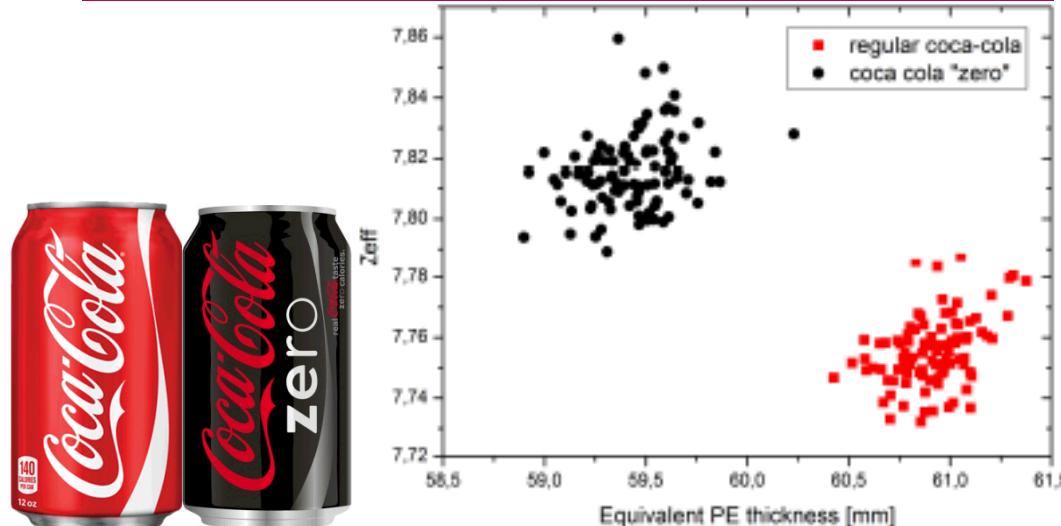
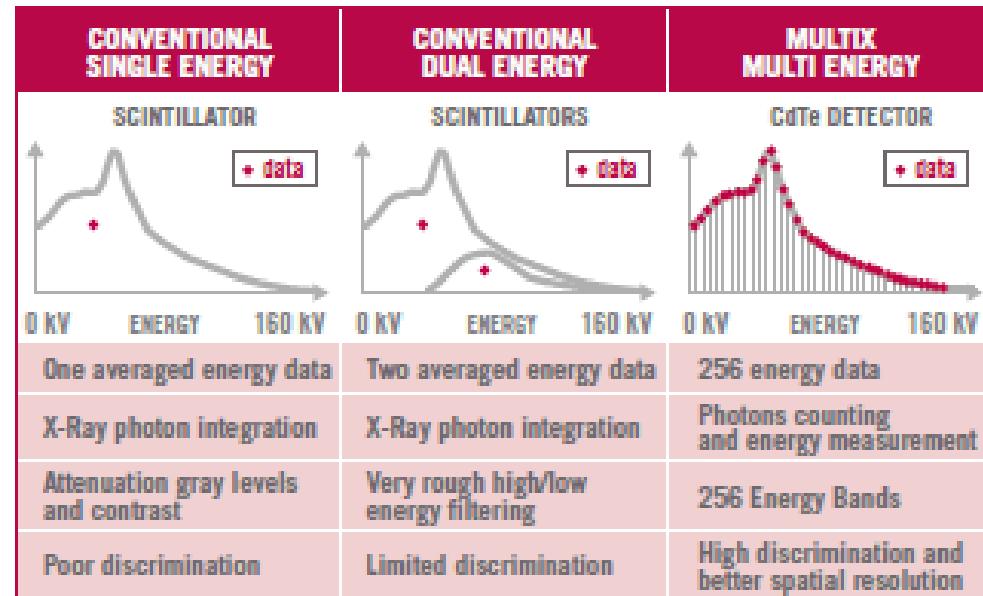
Example: LLNL

- Developed by Wurtz et. Al. in 2009
- Lawrence Livermore National Laboratories
- Evolution on Dual-energy Radiography Methods
- Does not require material thickness or geometry information

$$\left(\frac{\frac{I}{I_0}|_l}{\frac{I}{I_0}|_h}, \ln \left(\frac{I}{I_0}|_l \right) \right)$$

Solution: Energy Resolved Imaging

- Virtually mono-energetic energies.
 - Results in cleaner data for analysis and segmentation.
- Single scan for multi-energy data!
 - Reduce dose and scan time
- High Risk: Very new technology;
 - Large payoff for many engineering, science, and security applications that could significantly evolve each area.



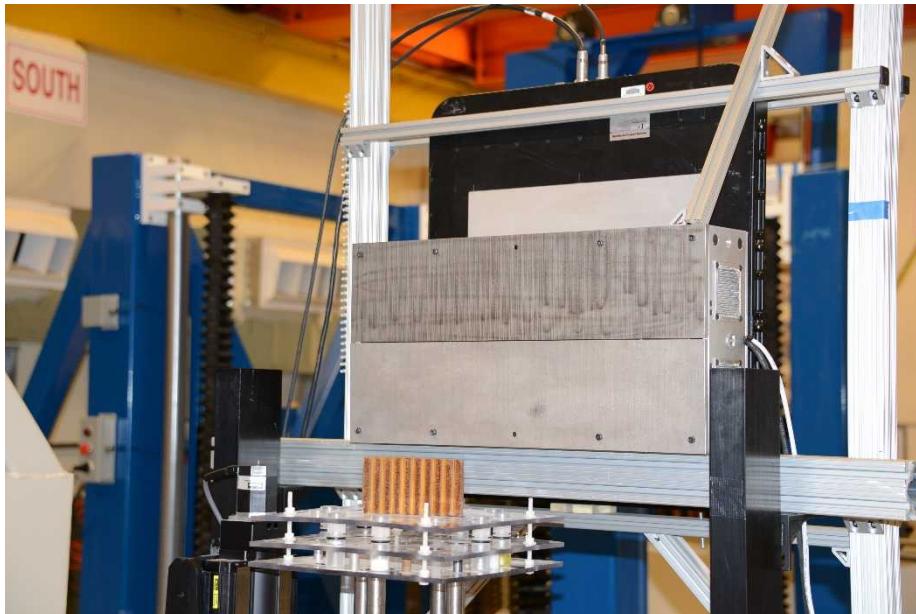
Energy Resolved Imaging in Medicine

- Dual-Energy Radiography
 - Bone Mineral Density
 - Tissue Emphasis
 - Material Removal
- Color X-ray Imaging
 - Low-Energy Applications
 - Some non-medical applications
 - Computed Tomography

Multix Detector

- Sandia has acquired a 5 module Linear Array Detector
 - Calibrated for up to 300 keV X-rays
 - Only one we know of in existence
 - 128 Pixels per Module / 640 Total Pixels
 - 1M Counts per second per pixel
 - 128 channels
 - ~2.34 keV wide channels
 - 0.5 meters wide
 - 0.8mm pixel pitch

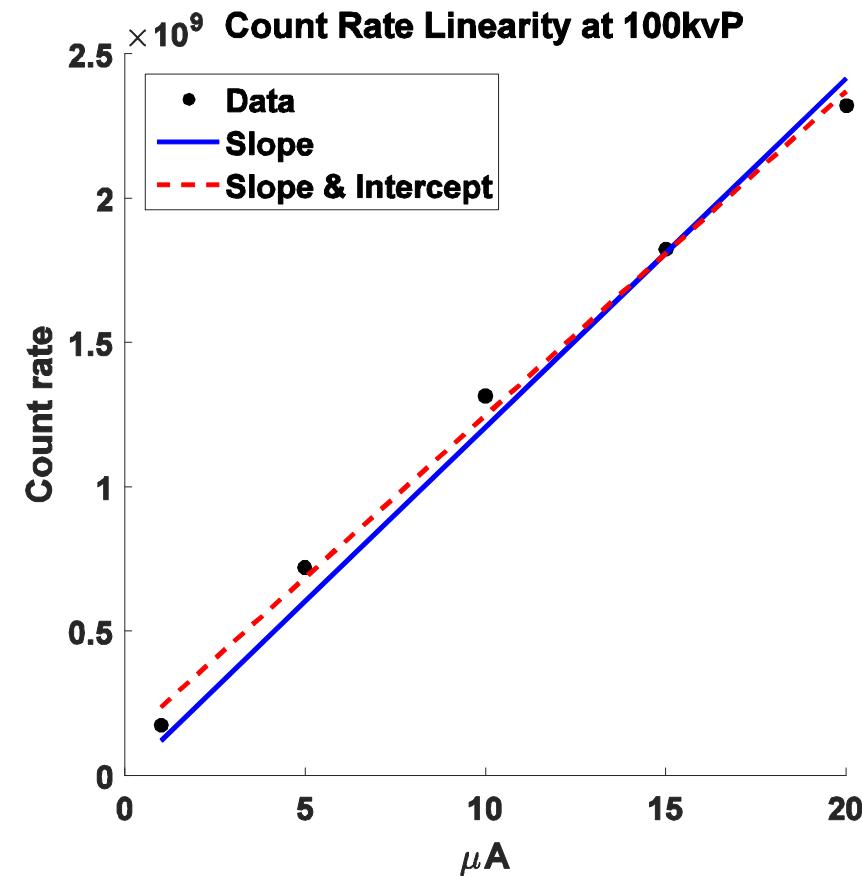
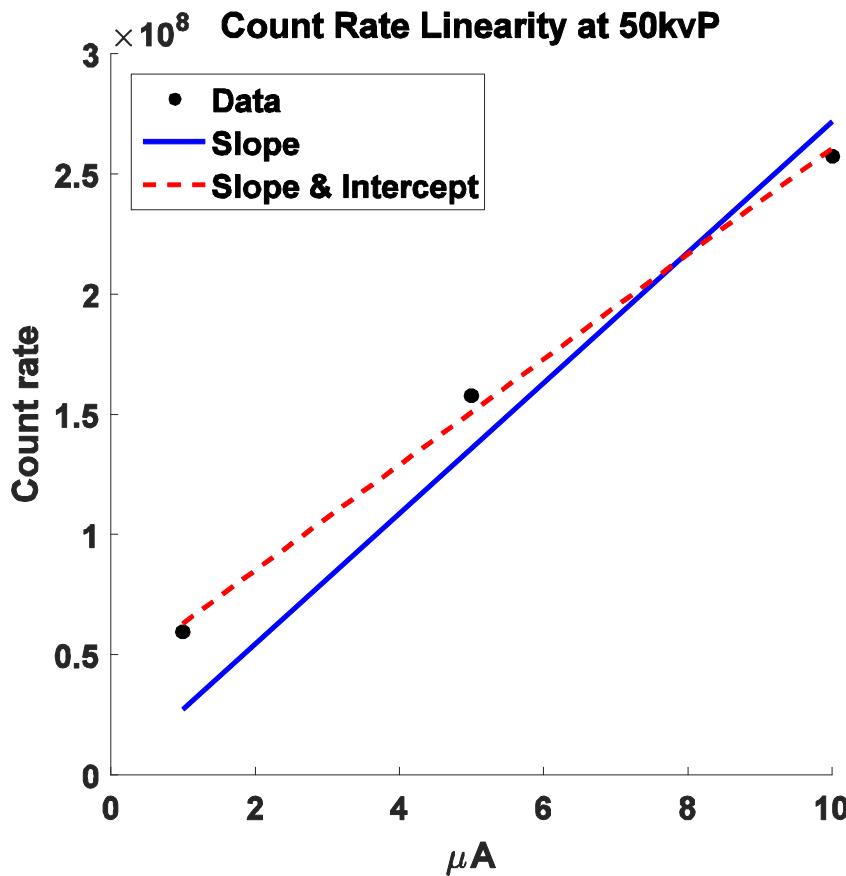
System Configuration



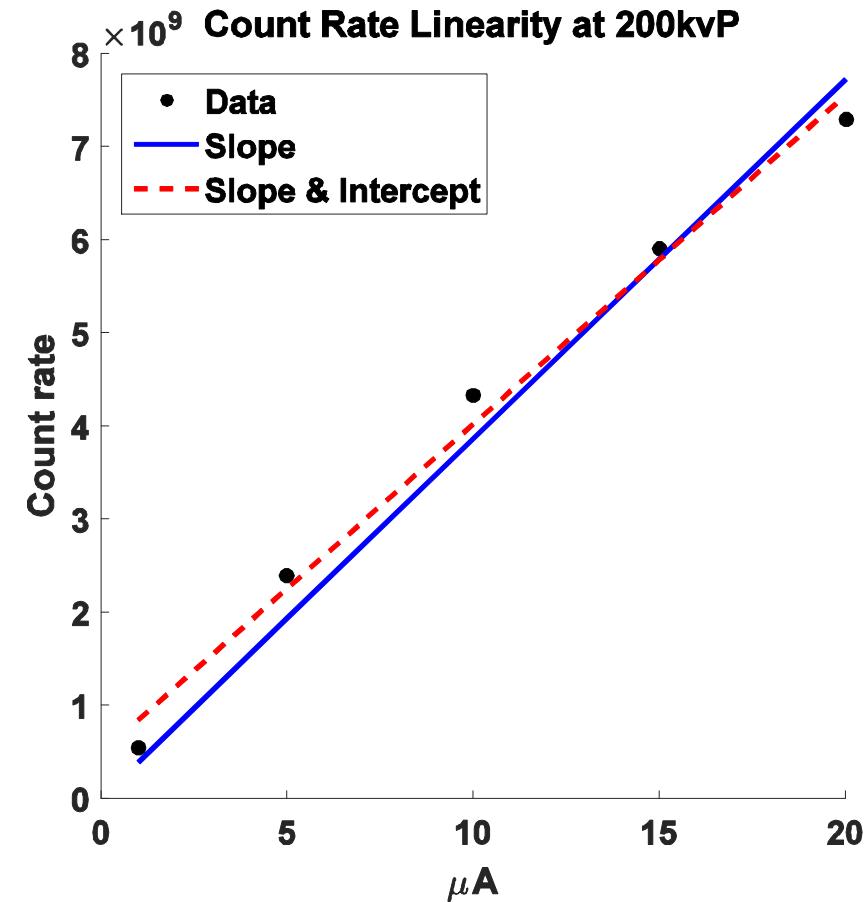
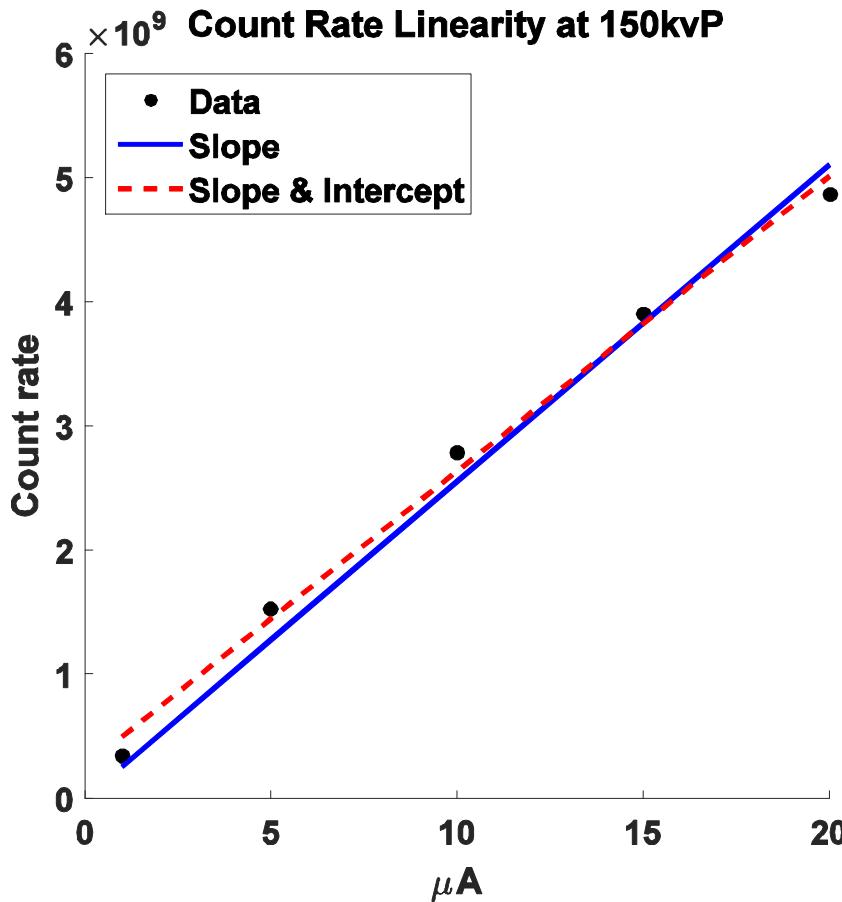
Technology Integration Experiments

- Count rates
 - 1M/pixel advertised
 - Test at various currents
- Attempt Metrics/Measurements
 - Collins et. Al.
 - LLNL Metric
- Mean pixel output
 - Materials of interest
- Normalized Spectrums
- SNR
 - Across Pixels
 - Across Energy
- System
 - Comet 450keV
 - Only run up to 300kVp
 - ~6 meter source to detector
 - Multix Detector
 - 128 Channels
 - 640 Pixels
- Materials (sheets)
 - Lead (0.76mm/0.03in)
 - Tin (0.813mm/0.032in)
 - Copper (0.2mm/0.008in)
 - Polyethylene (13.5mm/0.53in)
 - Water (59.2mm/2.33in)
 - Cubic plastic container

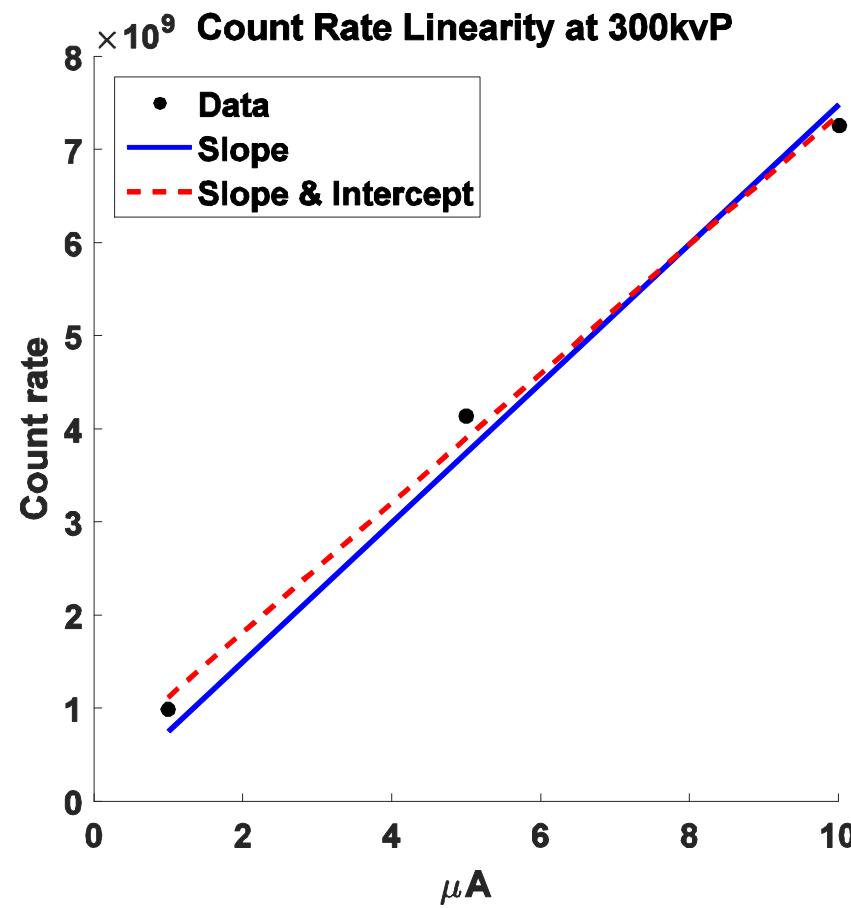
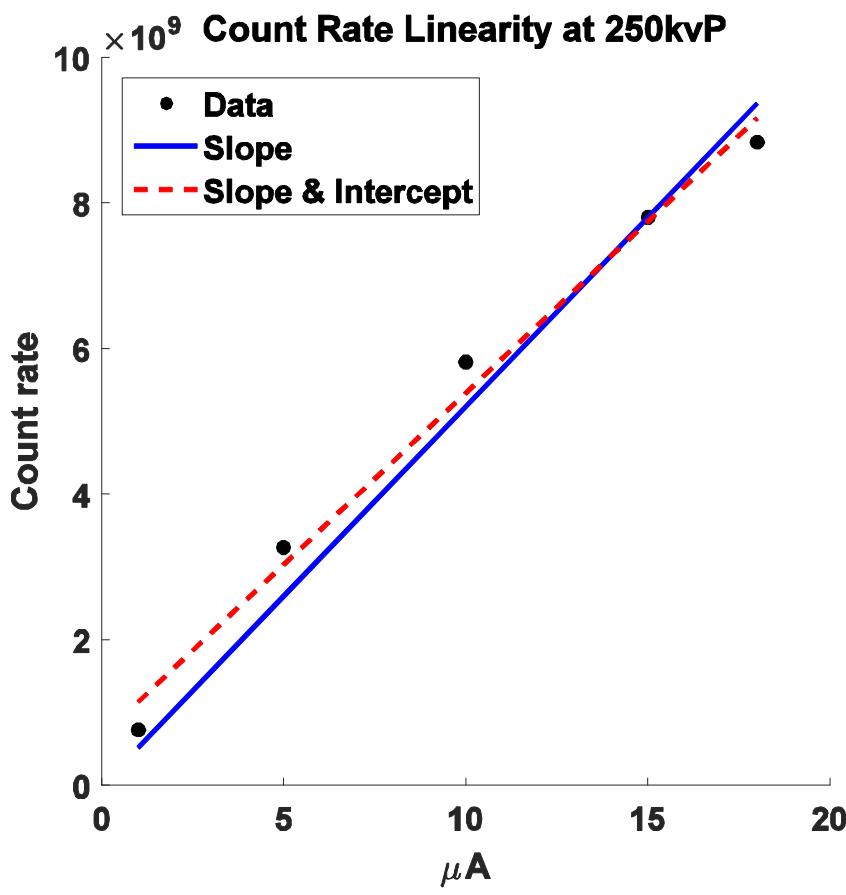
Count Rate 50 & 100keV



...150keV & 200keV



...250keV & 300keV



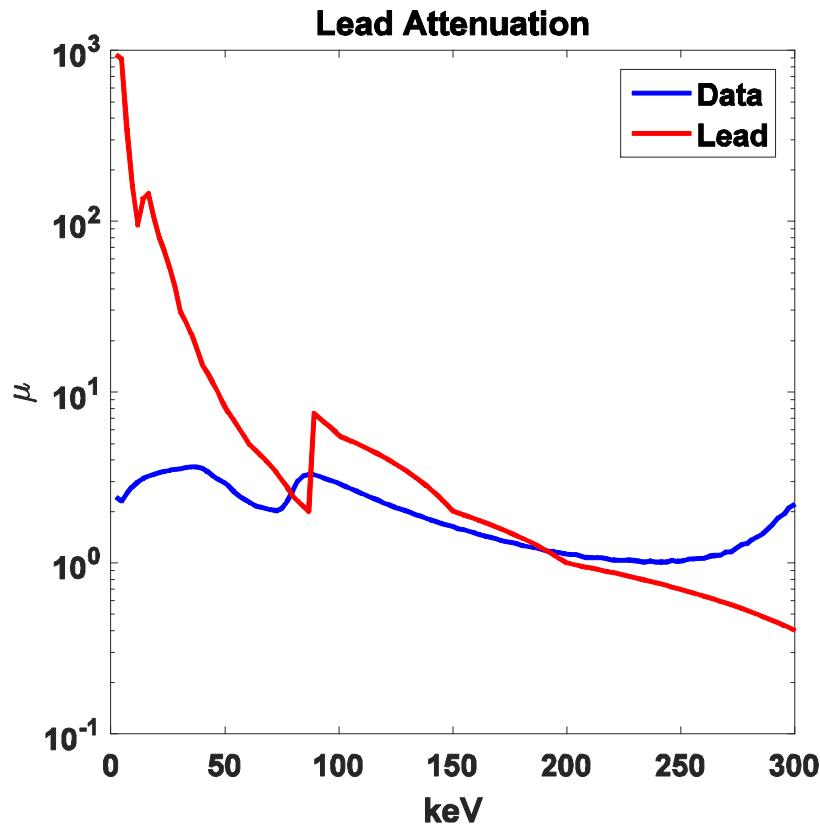
Direct Calculation

- Known information
 - Experimental Geometry
 - Material density and thickness
- Beer's Law
 - μ - linear attenuation coefficient
 - l – thickness
 - ρ - density
 - I_{in} - initial spectrum
 - I_{out} - attenuated spectrum

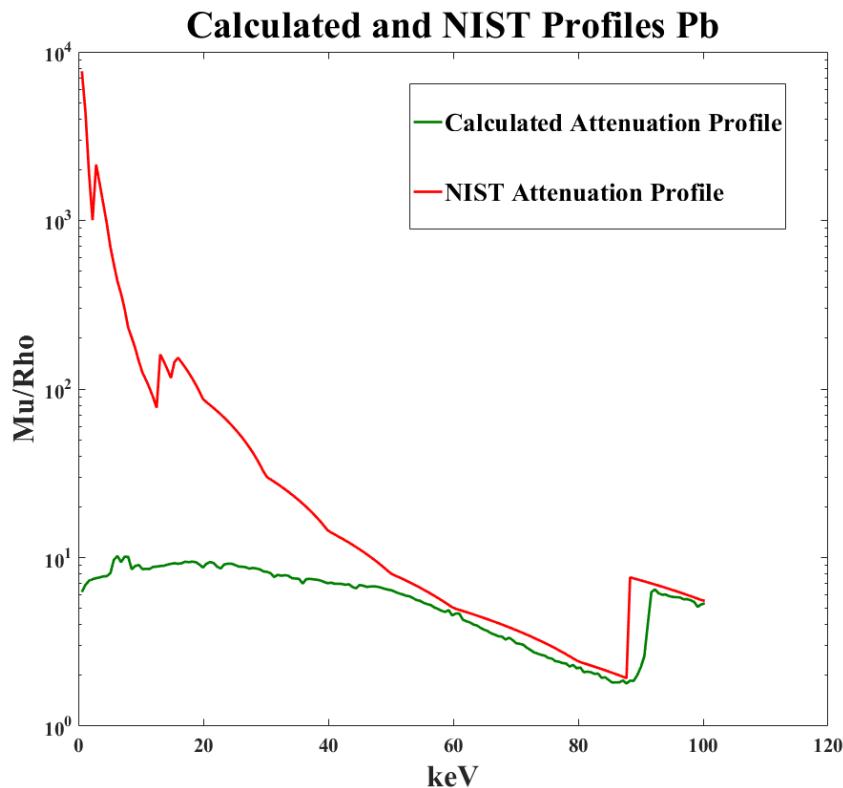
$$\frac{\mu}{\rho} = -\frac{1}{l} \cdot \frac{1}{\rho} \cdot \ln \left(\frac{I_{in}}{I_{out}} \right)$$

Lead Estimate

Multix

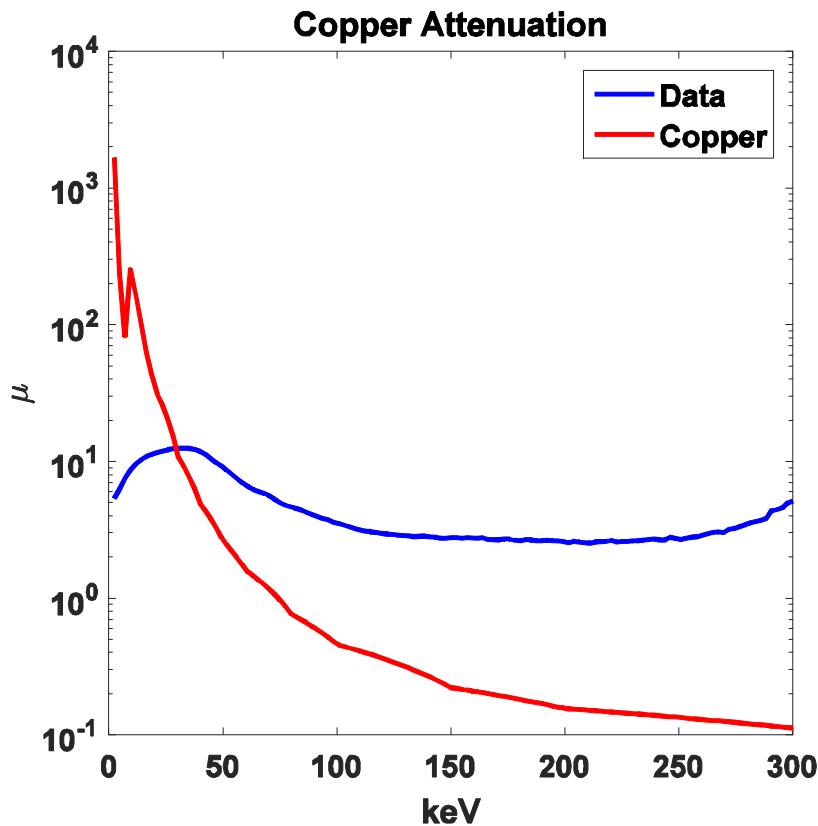


Amptek

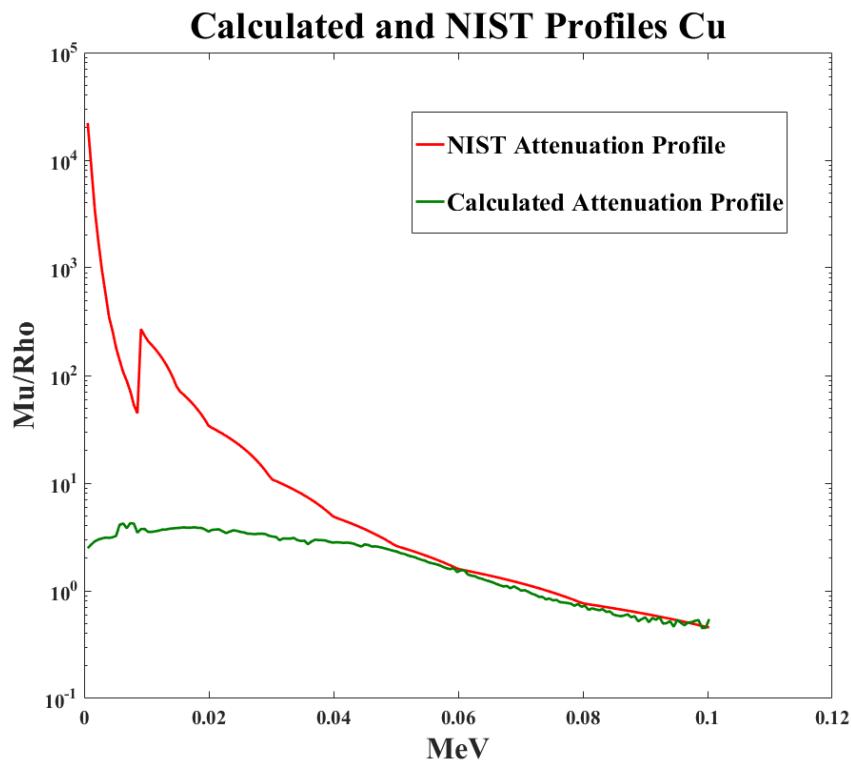


Copper Estimate

Multix

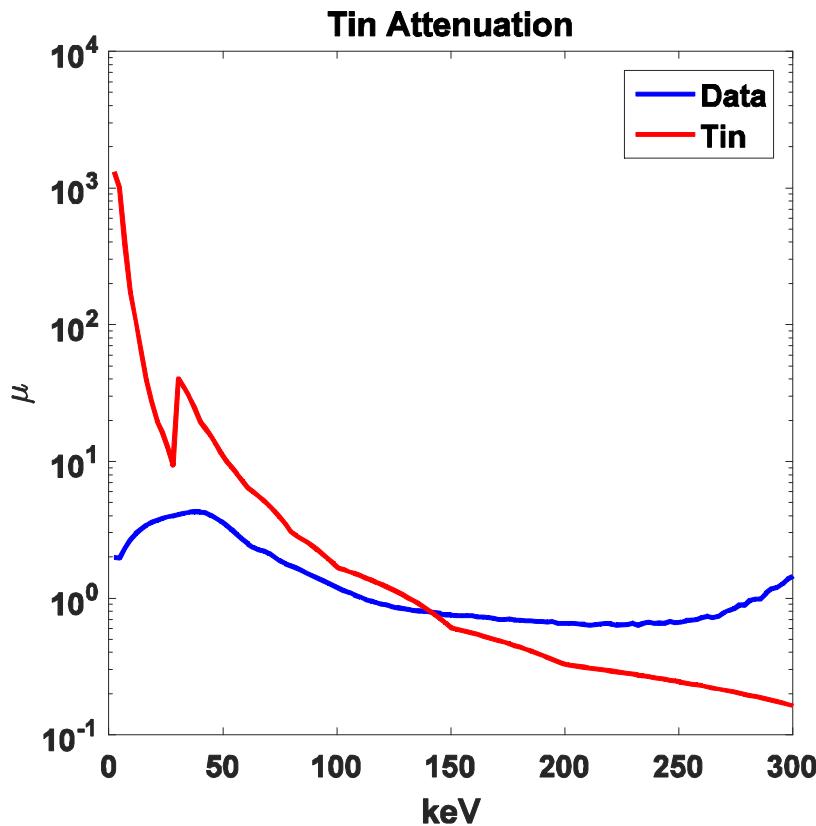


Amptek

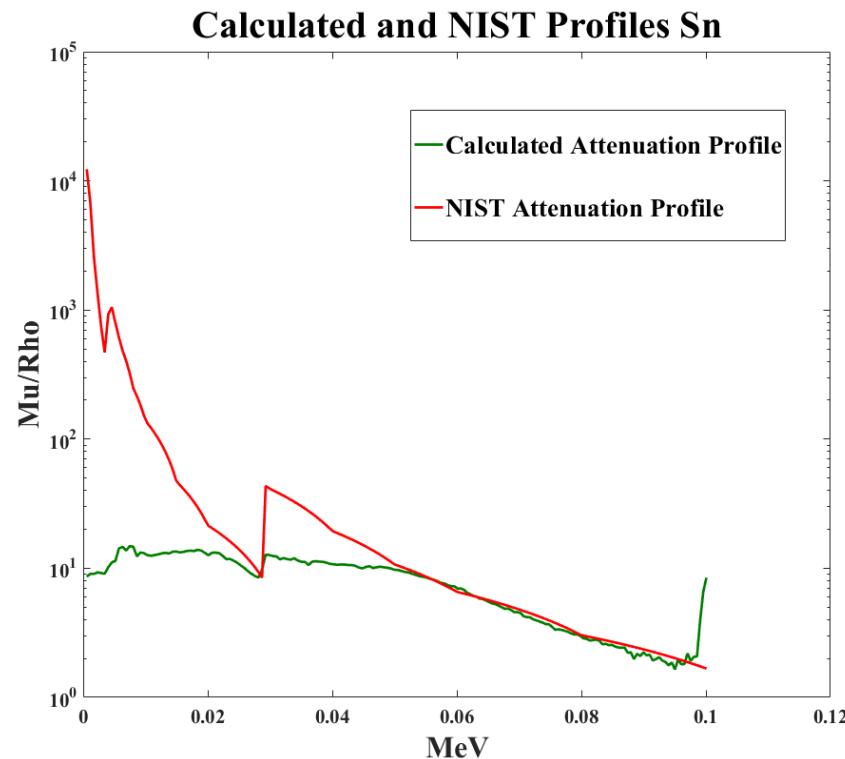


Tin Estimate

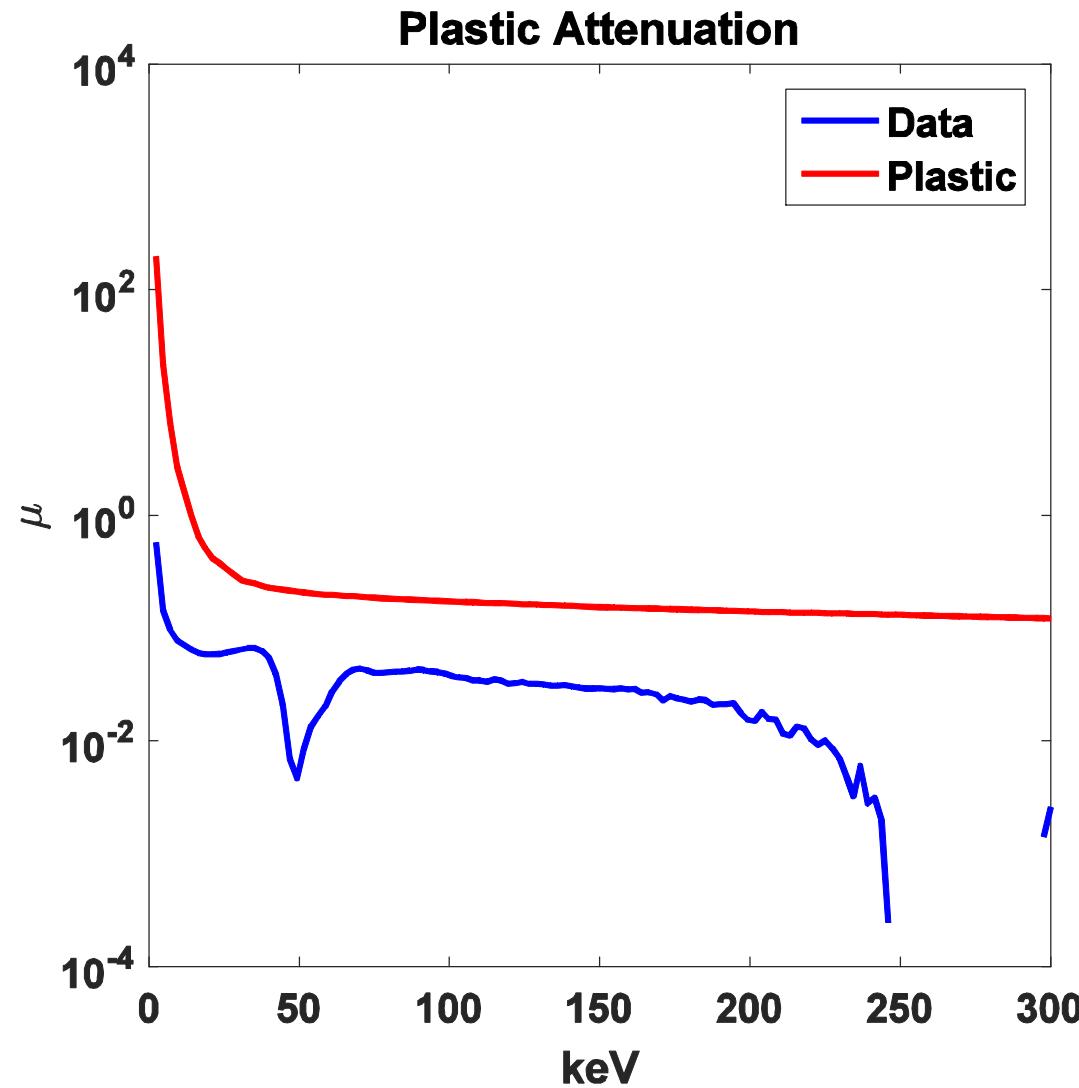
Multix



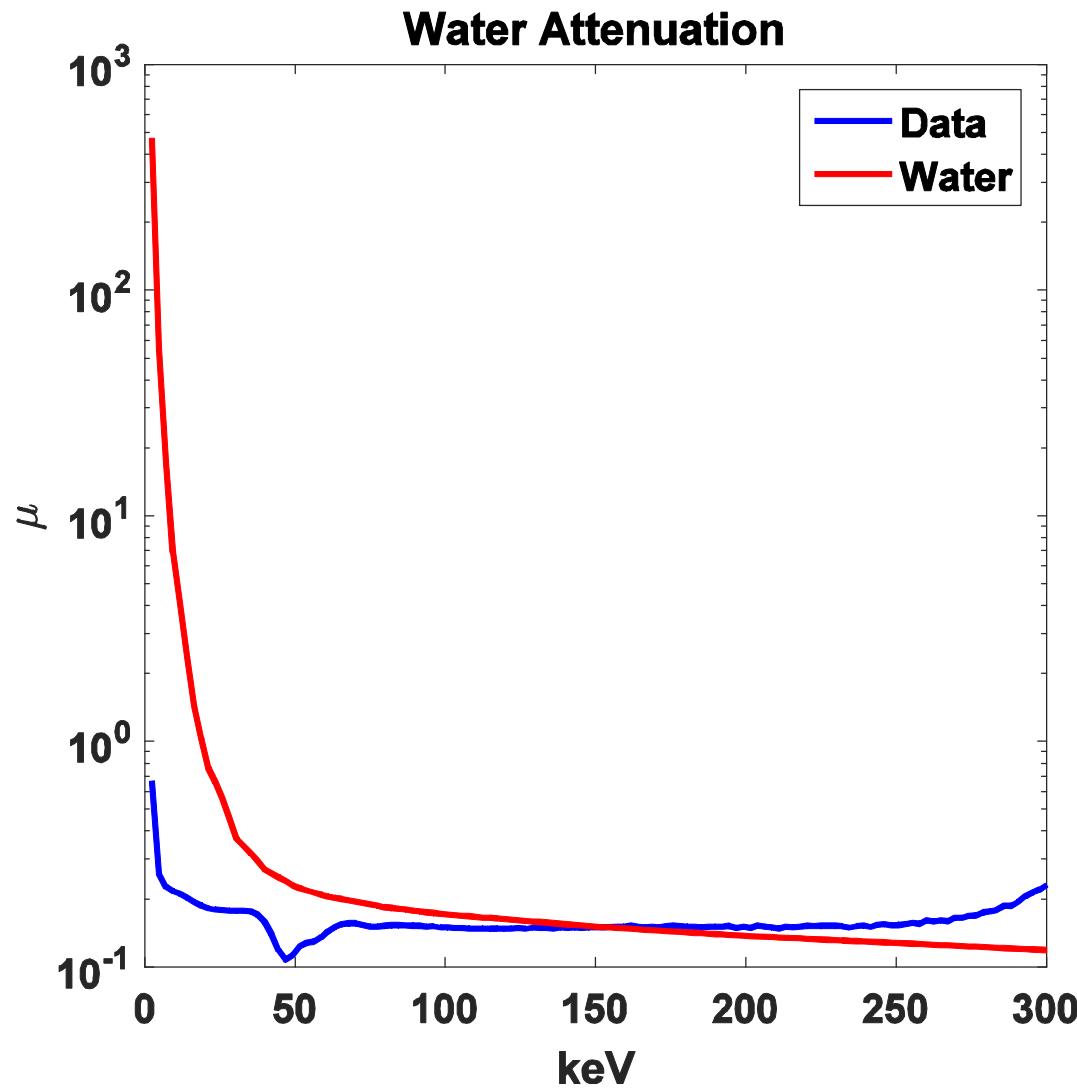
Amptek



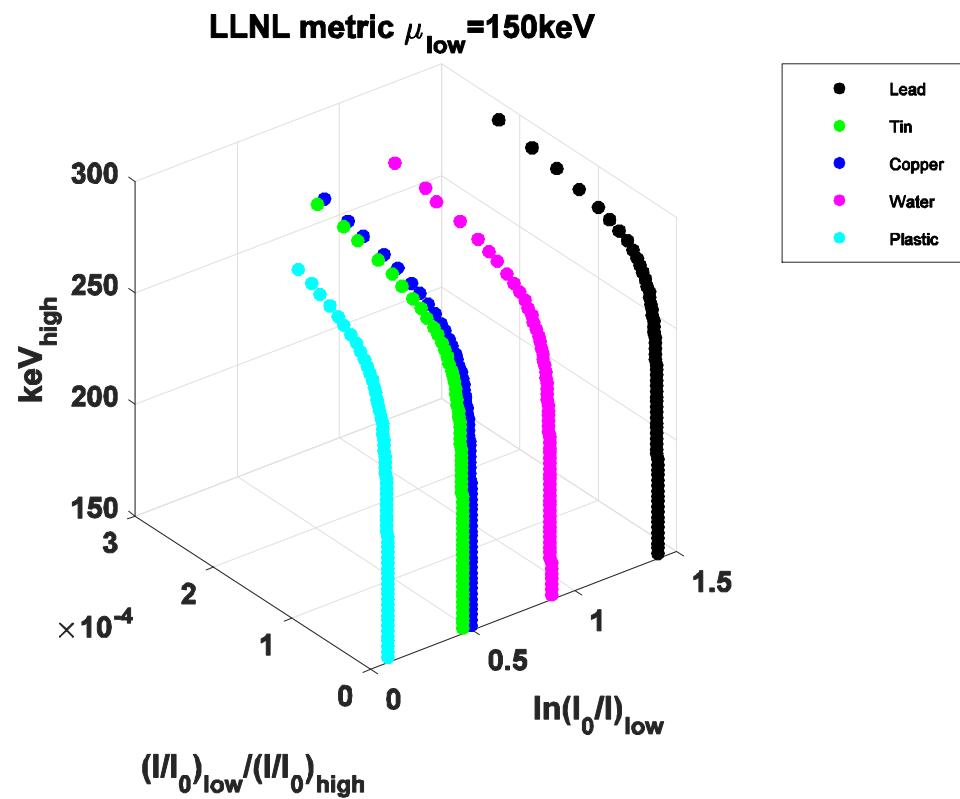
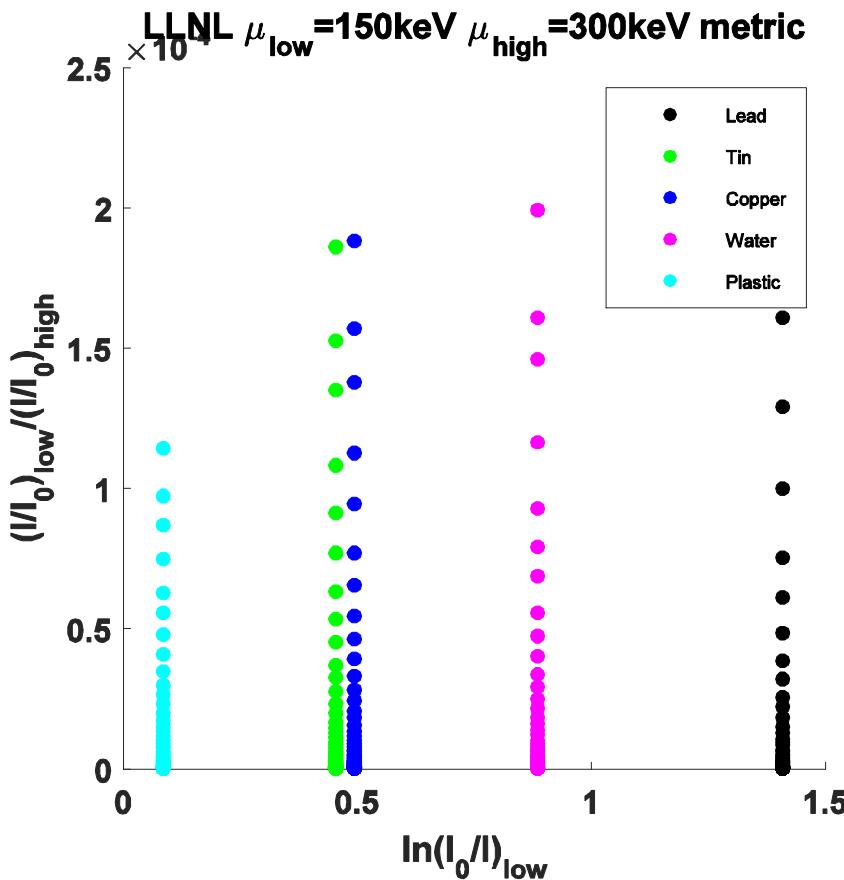
Polyethylene Estimate



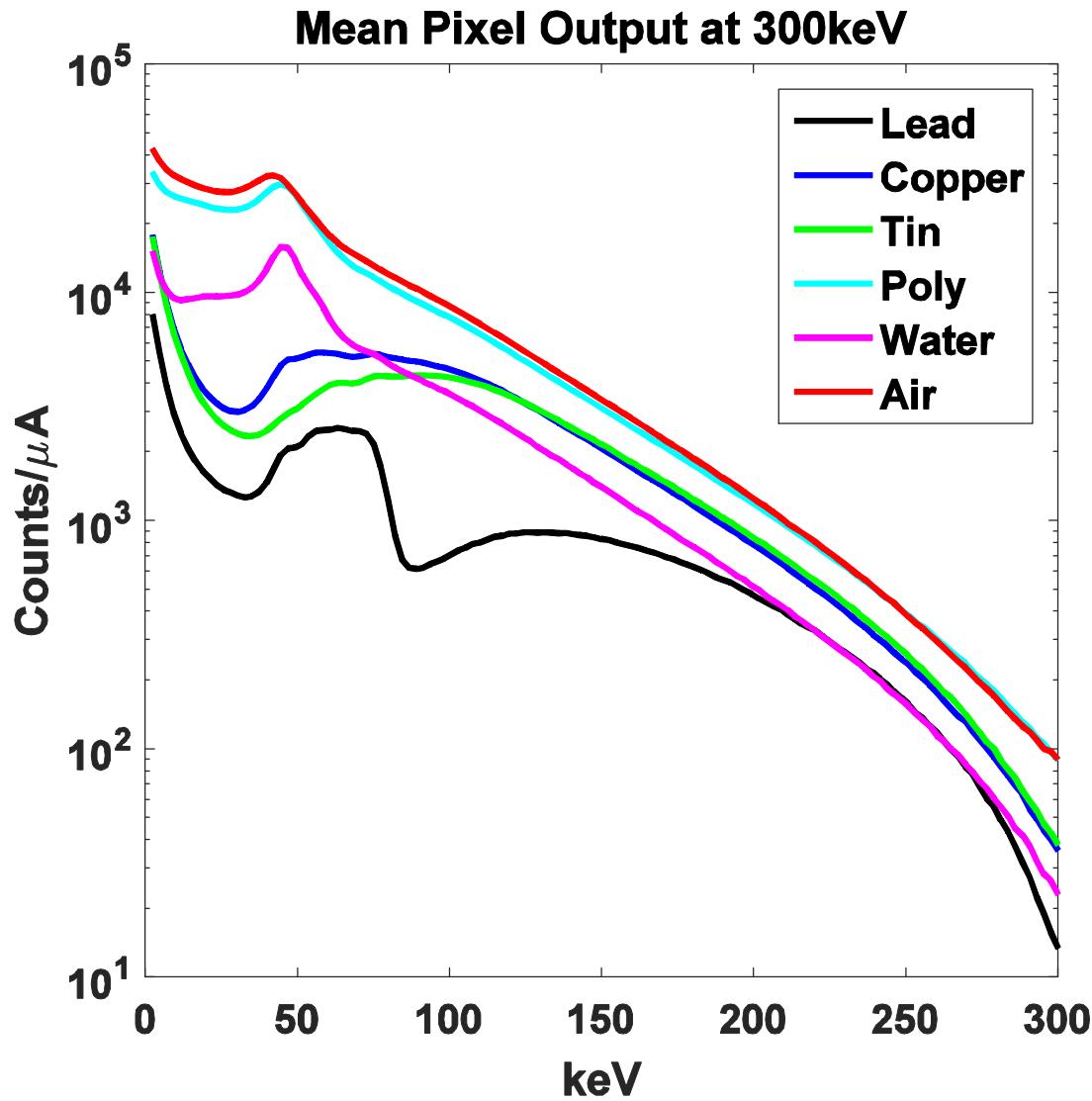
Water Estimate



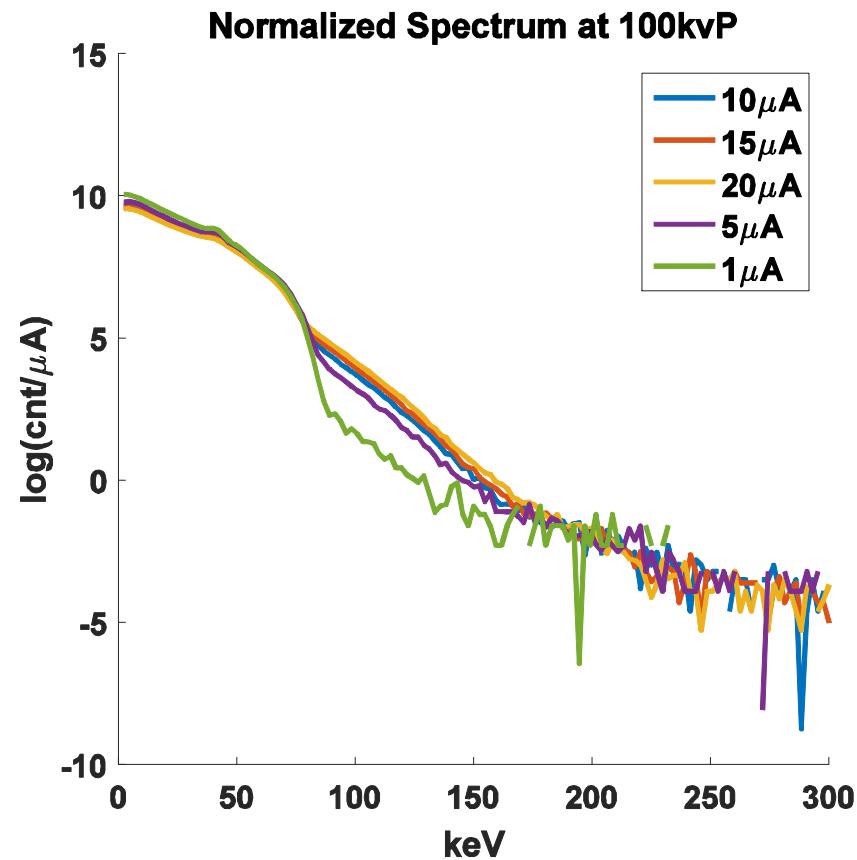
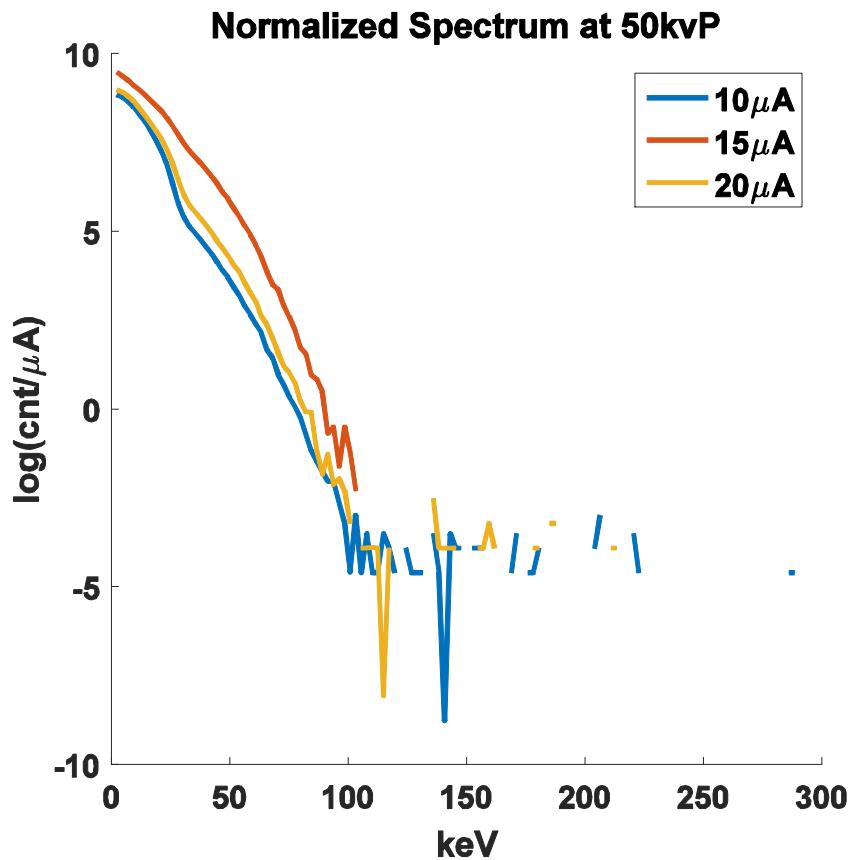
LLNL Metric



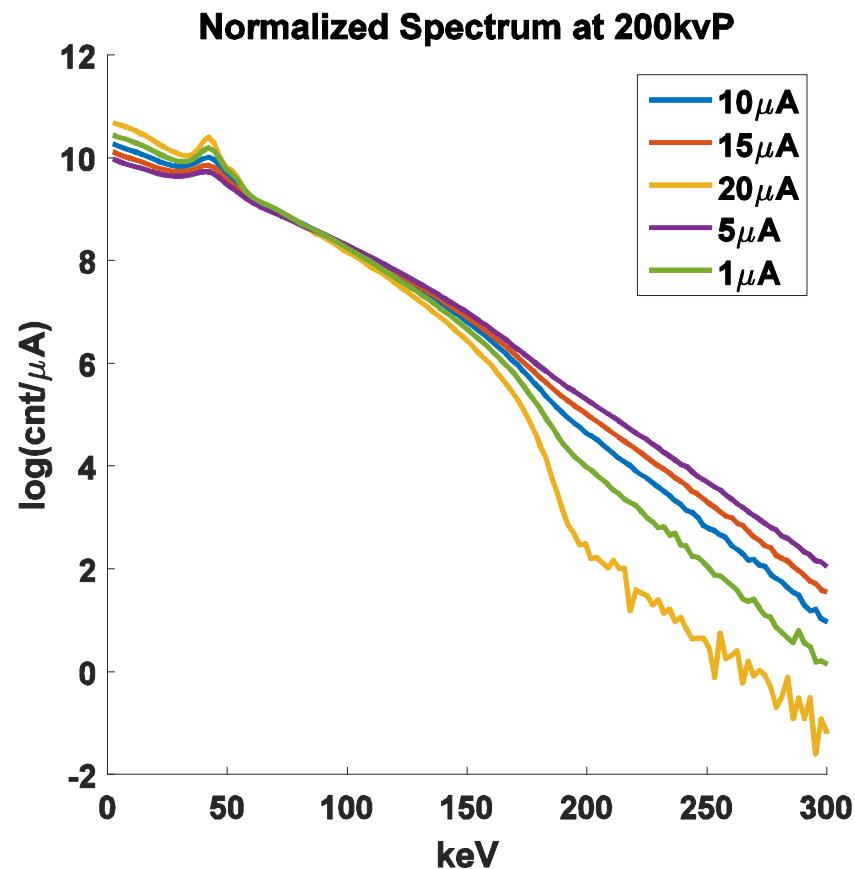
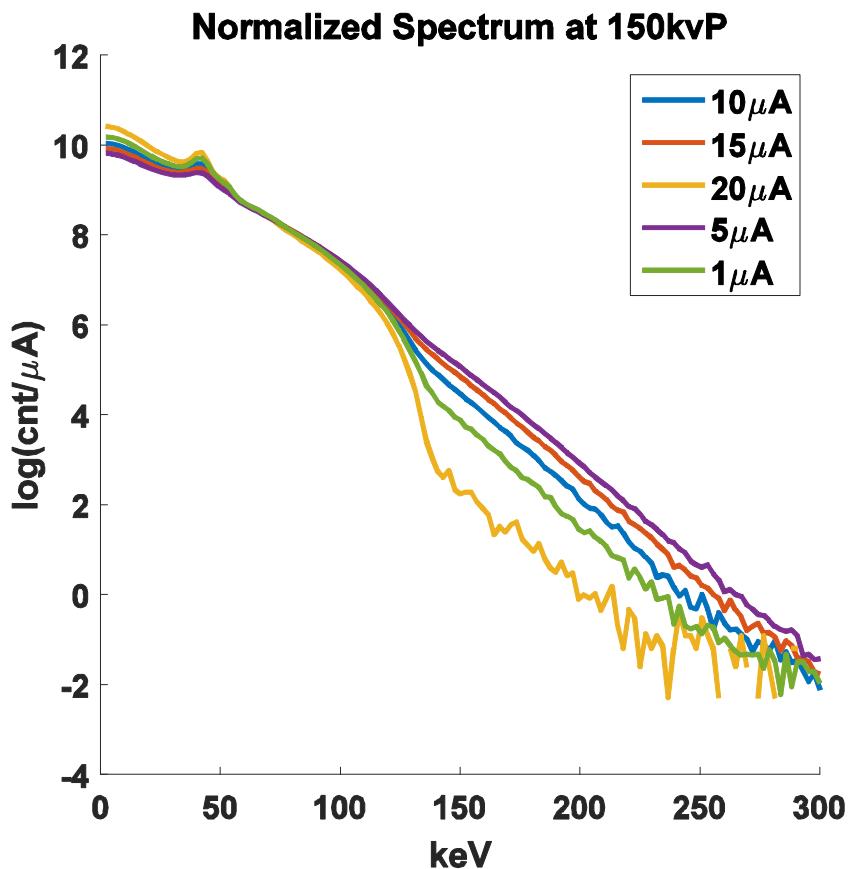
Mean Pixel Output



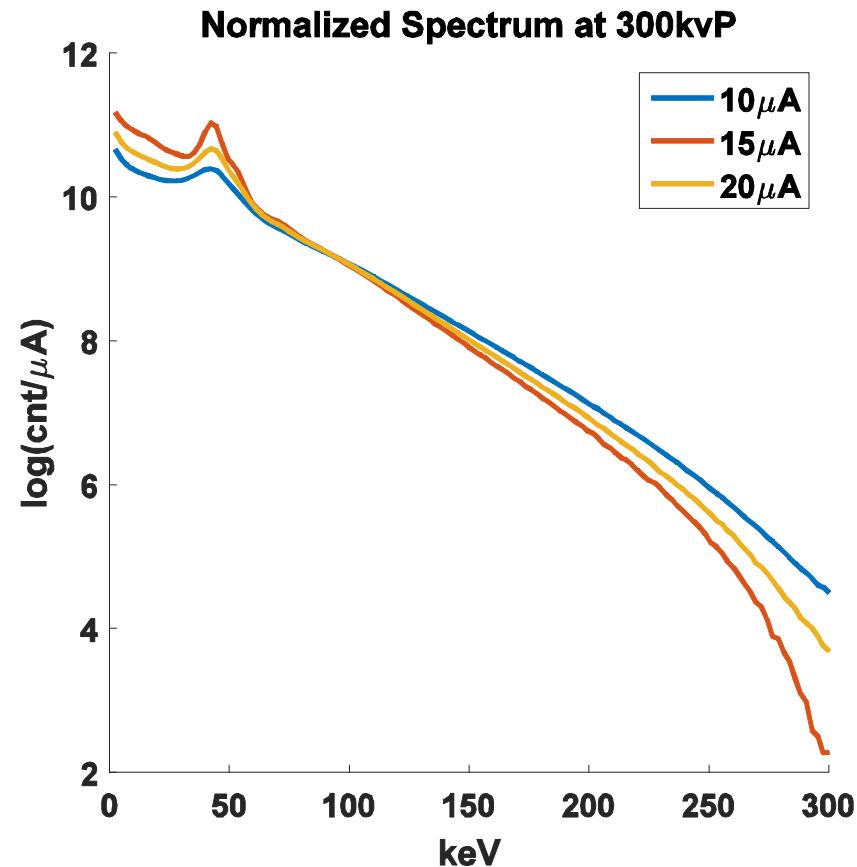
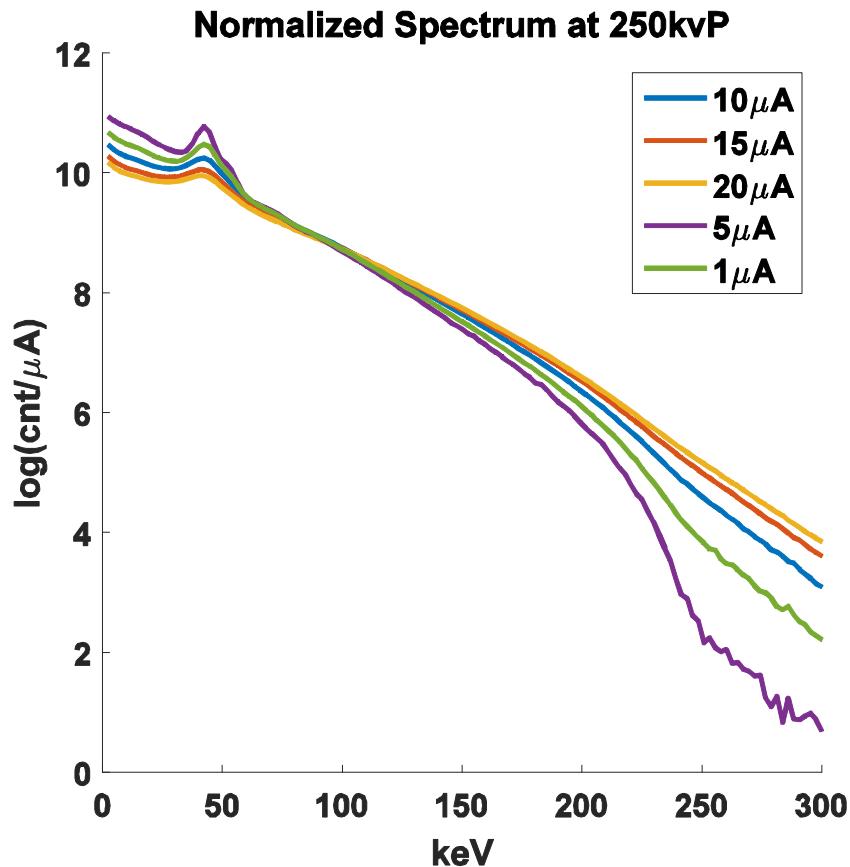
Normalized Spectrum 50 & 100keV

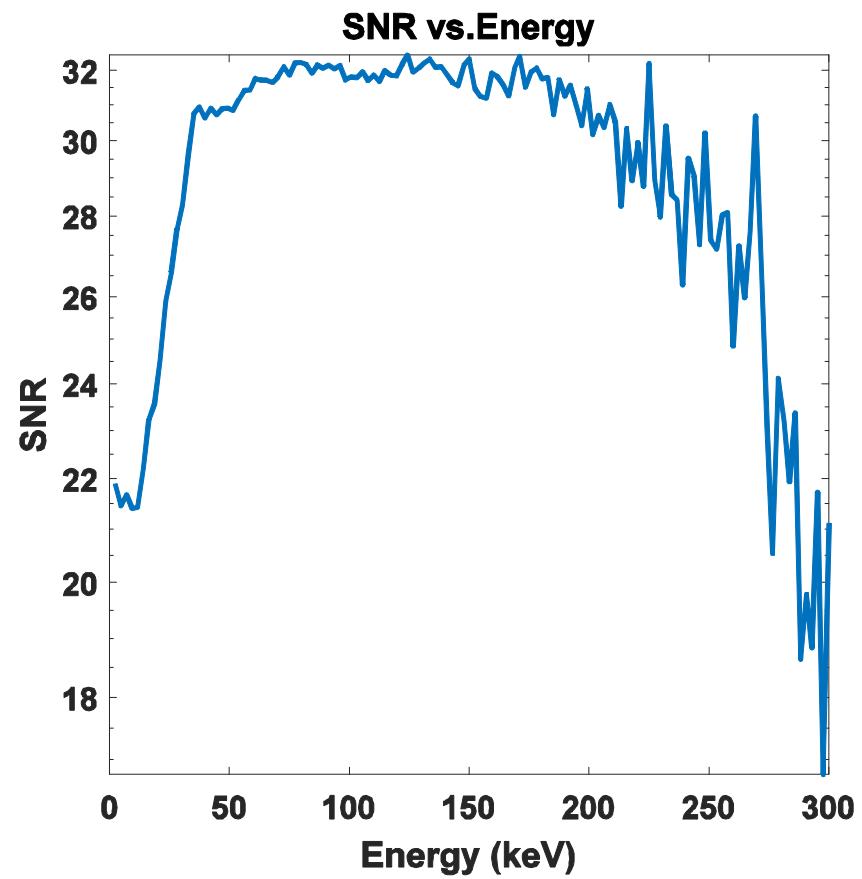
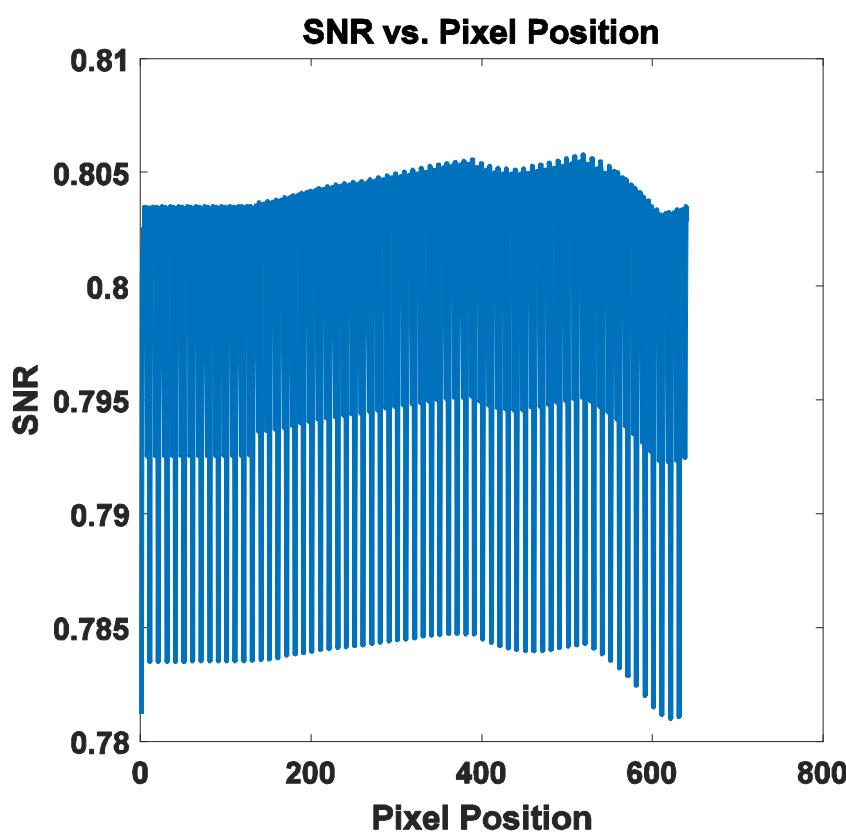


...150keV & 200 keV



...250keV & 300keV





Discussion

- Count Rate:
 - Multix exhibits great scalability for 50 to 300keV
 - Across array over 100M counts per second achieved
 - Crucial for 2D Imaging and CT
 - Detector did not seem to saturate with our maximum current
- Materials Identification
 - More work needed
 - Low energy attenuation estimation
 - Noise and Scatter?
 - Consistent with Amptek
 - High energy attenuation estimation
 - Generally overestimated
 - Detector efficiency causing overestimate?

- LLNL Metric
 - More consistent/tighter clustering possible?
 - Could dramatically improve performance of multiple systems
 - Need to test with more thicknesses
- Normalized Spectrum
 - Inflection point around 100keV?
 - Pulse-pileup is visible for kVP settings below 300kVP
 - Ideal detector should have perfect overlap of normalized spectrums
- SNR
 - Pixels: Cyclical SNR correlated with submodules?
 - Energy: ~50 to ~160keV yield best SNR?
 - Possibly expected as this was the original specification

Future Work

- Develop Software for more complex Scans
 - 2D Images
 - Computed Tomography Datasets
- Spectrum Corrections
- Issues Encountered:
 - Design issues
 - Alignment
 - Hyper- and Hyposensitivity
 - SDK Issues

Thank you

- Our team appreciates the opportunity to present our work.
- Questions?